


<b>Search Notes</b>  	<b>Application/Control No.</b>  10825242	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  YUK CHOW	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	76, 204,212	12/22/2008	YC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	12/22/2008	YC
sample holder could be transistors that hold data as in Kasai Fig. 6(42))	7/16/2009	YC
placement of sample holder is now taught by Kasai Fig. 3(cd)	12/31/2009	YC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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